

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Rutten, Ivo

Serial No.:

Filed:

Title: MICROPROCESSOR-BASED PROBE FOR INTEGRATED CIRCUIT TESTING

Atty. Docket No.: US 018205

Group Art Unit:

Examiner:



Honorable Commissioner of Patents and Trademarks
Washington, D.C. 20231

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

Sir:

Enclosed is an Information Disclosure Citation and copies of documents listed thereon.

These documents are considered to be relevant in that they have been:

- ☒ considered in drafting the specification of the above-referenced application;
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☐ cited as an "X" or "Y" document in a foreign Patent Office search report on a foreign counterpart application, a copy of which report is also enclosed;

☐ I hereby certify that these documents were cited in said search report not more than three (3) months ago.

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Respectfully submitted,

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